



INVITATION TO EXHIBIT

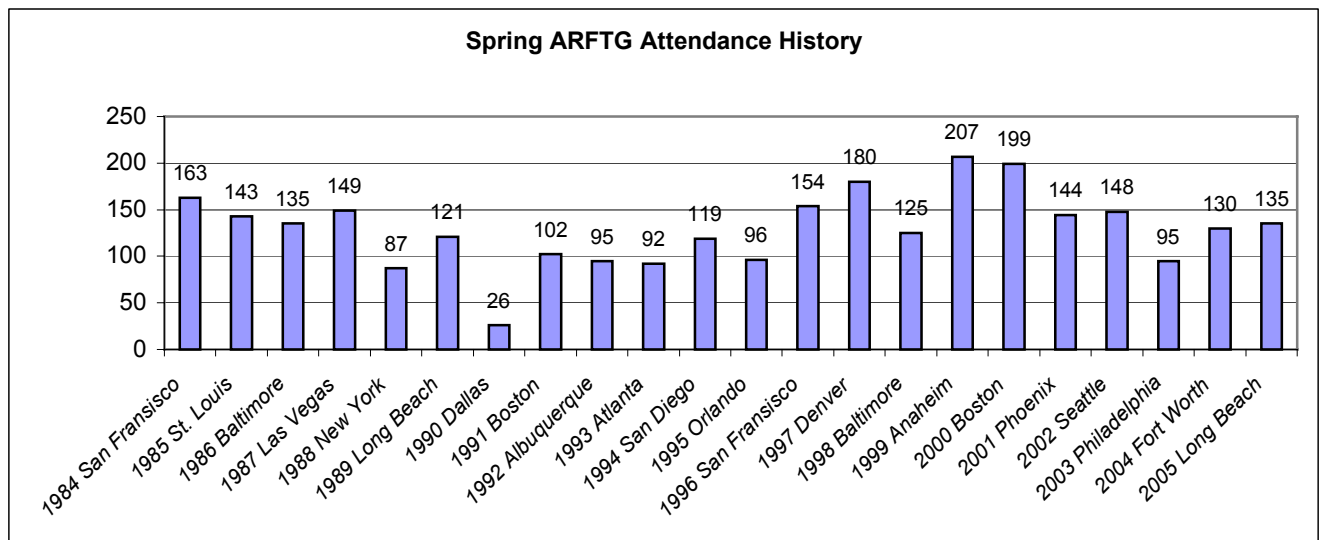
67th ARFTG CONFERENCE IEEE MTT-S IMS2006, San Francisco, California June 16th, 2006

In conjunction with the International Microwave Symposium, the Automatic RF Techniques Group will hold its 67th ARFTG Microwave Measurement Conference at the Renaissance Parc55 Hotel in San Francisco, California. The conference technical theme is “*Measurements and Design of High Power Devices and Systems*” and will also cover other aspects of microwave measurement.

During this conference there will be an exhibits area for the display of microwave measurement equipment, simulation tools, and associated products. On behalf of the Exhibits Committee I would like to extend an invitation to exhibit. This is an excellent opportunity to present your company’s latest products and techniques to an exceptionally qualified audience.

The exhibits area will be adjacent to the technical program hall, which will ensure exposure to all of the conference participants. This is a valuable opportunity to exhibit your products to a focused measurement community in the comfortable, personal atmosphere afforded by ARFTG.

The exhibitor application and rules document is attached. Please contact me if you have any questions about this opportunity. I hope that you will join us in San Francisco!



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